

SN75ALS085

LAN ACCESS UNIT INTERFACE DUAL DRIVER/RECEIVER

SLLS054B – APRIL 1989 – REVISED MAY 1995

description (continued)

The purpose of the loop functions is to provide a means by which system data path verification can be done to isolate faulty interfaces and assist in network diagnosis. The LOOP pins are TTL compatible and must be held high for normal operation. When $\overline{\text{LOOP1}}$ is taken low, the output of driver 1 (TXO1) immediately goes into the idle state. Also, the input to receiver 1 is ignored and a path from TXI1 to RXO1 is established. When $\overline{\text{LOOP1}}$ is taken back high, driver 1 and receiver 1 revert back to their normal operation. When $\overline{\text{LOOP2}}$ is taken low, a similar data path is established between TXI1 and RXO2. TXEN1 must be high for the loop functions to operate and TXEN1 can be used to gate the loop function if desired. During loop operation, the respective receiver enable output (RXEN) will reflect the status of TXEN1.

Function Tables

RECEIVER – $\overline{\text{LOOP}} = \text{H}$

RXI	PREVIOUS RXEN	OUTPUTS	
		RXEN	RXO
$V_{ID} = 1315 \text{ mV to } -175 \text{ mV}, t_w < 25 \text{ ns}$	L	L	H
$V_{ID} = -275 \text{ mV to } -1315 \text{ mV}, t_w > 50 \text{ ns}$	X	H	L
$V_{ID} = 318 \text{ mV to } 1315 \text{ mV}, t_w < 142 \text{ ns}$	H	H	H
$V_{ID} = 318 \text{ mV to } 1315 \text{ mV}, t_w > 187 \text{ ns}$	X	L	H

H = high level, L = low level, X = don't care

DRIVER – $\overline{\text{LOOP}} = \text{H}$

TXI	TXEN	PREVIOUS TXO	OUTPUT TXO
L	L	Idle	Idle
H	L	Idle	Idle
↓	H	Idle	L
L	H	Active	L
$H < 260 \mu\text{s}$	H	Active	H
$H > 8 \mu\text{s}$	H	Active	Idle
L	$L > 8 \mu\text{s}$	Active	Idle
$H < 260 \text{ ns}$	$L > 8 \mu\text{s}$	Active	Idle
$H < 260 \text{ ns}$	$L < 260 \text{ ns}$	Active	H
$H > 8 \mu\text{s}$	$L < 260 \text{ ns}$	Active	Idle
L	$L < 260 \text{ ns}$	Active	L

$H = V_I \geq V_T \text{ max}, L = V_I \leq V_T \text{ min}$



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Function Tables (continued)

LOOP										
INPUTS						OUTPUTS				
LOOP1	LOOP2	TXI1	TXEN1	RXI1	RXI2	RXO1	RXO2	RXEN1	RXEN2	TXO1
L	L	L	H	X	X	L	L	H	H	Idle
L	L	H	H	X	X	H	H	H	H	Idle
L	L	X	L	X	X	H	H	L	L	Idle
L	H	L	H	X	Normal	L	Normal	H	Normal	Idle
L	H	H	H	X	Normal	H	Normal	H	Normal	Idle
L	H	X	L	X	Normal	H	Normal	L	Normal	Idle
H	L	L	H	Normal	X	Normal	L	Normal	H	Idle
H	L	H	H	Normal	X	Normal	H	Normal	H	Idle
H	L	X	L	Normal	X	Normal	H	Normal	L	Idle
H	H	Normal	Normal	Normal	Normal	Normal	Normal	Normal	Normal	Normal

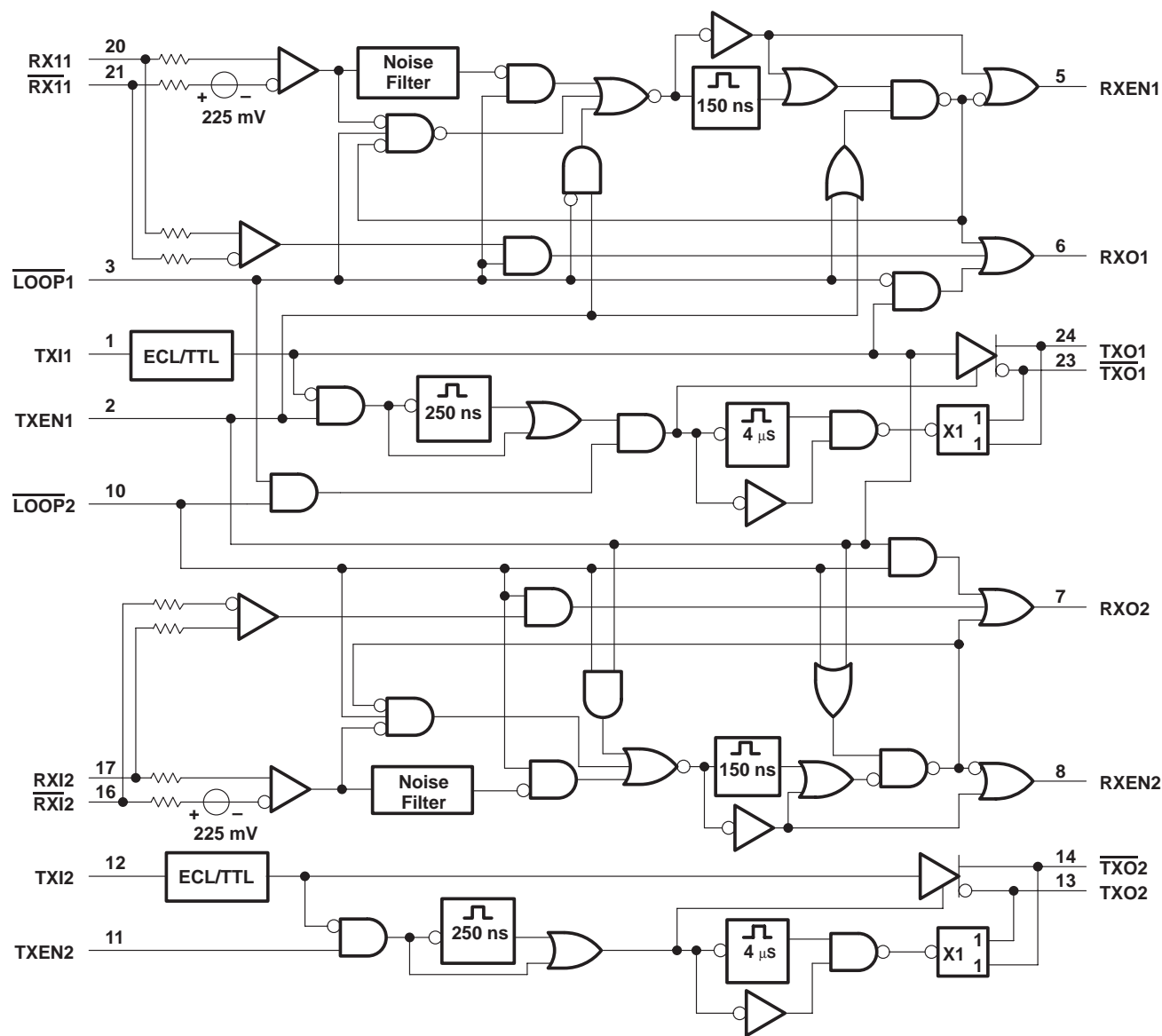
H = high level, L = low level, X = don't care



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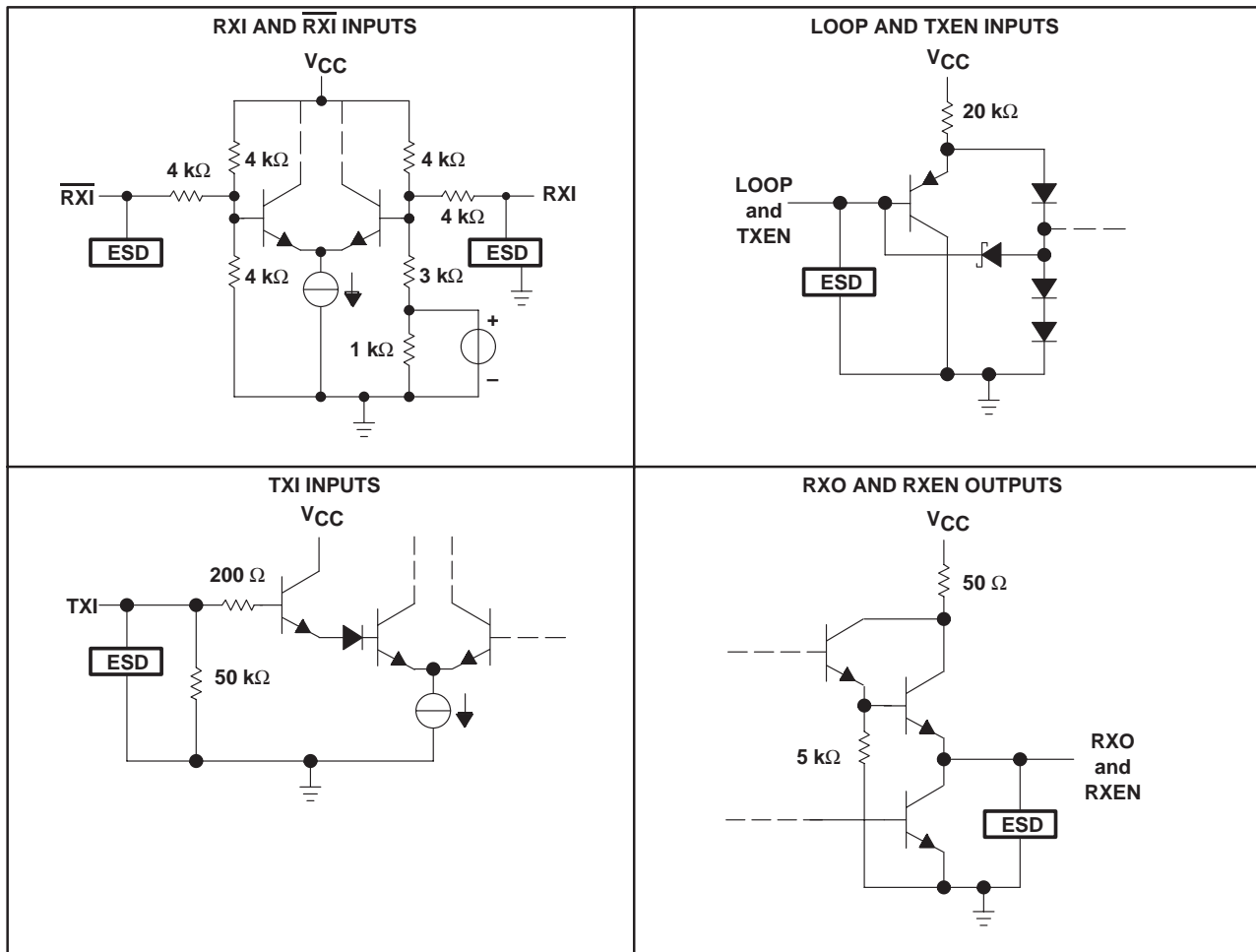
logic diagram (positive logic)



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schematics of inputs and outputs



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1)	6 V
TXI and \overline{LOOP} input voltage, V_I	5.5 V
TXO and \overline{TXO} output voltage, V_O	16 V
RXI and \overline{RXI} input voltage, V_I	16 V
RXO and RXEN output voltage, V_O	5.5 V
Continuous total power dissipation	See Dissipation Rating Table
Operating free-air temperature range, T_A	0°C to 70°C
Storage temperature range, T_{stg}	-65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

NOTE 1: Voltage values are with respect to network ground terminal.

DISSIPATION RATING TABLE

PACKAGE	$T_A \leq 25^\circ\text{C}$ POWER RATING	DERATING FACTOR ABOVE $T_A = 25^\circ\text{C}$	$T_A = 70^\circ\text{C}$ POWER RATING
DW	1350 mW	10.8 mW/°C	864 mW
NT	1250 mW	10.0 mW/°C	800 mW

recommended operating conditions

	MIN	NOM	MAX	UNIT
Supply voltage, V_{CC}	4.75	5	5.25	V
Common-mode voltage at RXI inputs, V_{IC}	1		4.2	V
Differential voltage between RXI inputs, V_{ID}	±318		±1315	mV
High-level input voltage, \overline{LOOP} and TXEN, V_{IH}	2			V
Low-level input voltage, \overline{LOOP} and TXEN, V_{IL}			0.8	V
High-level output current, RXO and RXEN, I_{OH}			-0.4	mA
Low-level output voltage, RXO and RXEN, I_{OL}			16	mA
Setup time, driver mode, TXEN high before TXI↓, t_{su1} (see Figure 7)	10			ns
Setup time, loop mode, \overline{LOOP} low before TXEN↑, t_{su2} (see Figure 9)	15			ns
Setup time, loop mode, TXEN high before TXI↓, t_{su3} (see Figure 9)	10			ns
Hold time, loop mode, TXEN high after TXI↑, t_{h1} (see Figure 8)	10			ns
Hold time, loop mode, \overline{LOOP} low after TXEN↓, t_{h2} (see Figure 8)	15			ns
Operating free-air temperature, T_A	0		70	°C



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electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	MAX	UNIT
V_{IK}	Clamp voltage at all inputs	$I_I = -18 \text{ mA}$		-1.5		V
$V_{(TO)}$	Driver input (TXI) threshold voltage	$T_A = 0^\circ\text{C}$	$V_{CC} = 4.75 \text{ V}$	3.202	3.752	V
			$V_{CC} = 5 \text{ V}$	3.389	3.998	
			$V_{CC} = 5.25 \text{ V}$	3.577	4.244	
		$T_A = 25^\circ\text{C}$	$V_{CC} = 4.75 \text{ V}$	3.213	3.797	V
			$V_{CC} = 5 \text{ V}$	3.400	4.043	
			$V_{CC} = 5.25 \text{ V}$	3.588	4.289	
		$T_A = 70^\circ\text{C}$	$V_{CC} = 4.75 \text{ V}$	3.239	3.849	V
			$V_{CC} = 5 \text{ V}$	3.426	4.095	
			$V_{CC} = 5.25 \text{ V}$	3.614	4.341	
Receiver differential input threshold voltage				-275		mV
V_{OC}	Driver output (TXO) common-mode voltage	Idle	$\overline{\text{TXEN}}$ at 0.8 V, $\overline{\text{LOOP2}}$ at 2 V, $\overline{\text{LOOP1}}$ at 2 V, See Figure 1	1	4.2	V
		Active	$\overline{\text{TXEN}}$ at 2 V, $\overline{\text{LOOP2}}$ at 2 V, See Figure 1	1	4.2	
		Active	$\overline{\text{TXEN}}$ at 2 V, $\overline{\text{LOOP2}}$ at 2 V, See Figure 1	1	4.2	
V_{OD}	Driver output (TXO) differential voltage	Idle	$\overline{\text{TXEN}}$ at 0.8 V, $\overline{\text{LOOP2}}$ at 2 V, $\overline{\text{LOOP1}}$ at 2 V, See Figure 1	± 40		mV
		Active	$\overline{\text{TXEN}}$ at 2 V, $\overline{\text{LOOP2}}$ at 2 V, See Figure 1	-600	1315	
		Active	$\overline{\text{TXEN}}$ at 2 V, $\overline{\text{LOOP2}}$ at 2 V, See Figure 1	600	1315	
V_{OH}	High-level output voltage	R XO, RXEN	$I_{OH} = -0.4 \text{ mA}$	2.4		V
V_{OL}	Low-level output voltage	R XO, RXEN	$I_{OL} = 16 \text{ mA}$		0.5	V
I_{IH}	High-level input current	$\overline{\text{TXEN}}, \overline{\text{LOOP}}$	$V_I = 2 \text{ V}$	20		μA
		TXI	$V_I = 4.5 \text{ V}$	400		
		$\overline{\text{RXI}}, \text{RXI}$	$V_{ID} = -0.5 \text{ V}, V_{IC} = 1 \text{ V to } 4.2 \text{ V}$	1000		
I_{IL}	Low-level input current	$\overline{\text{TXEN}}, \overline{\text{LOOP}}$	$V_I = 0.8 \text{ V}$	-200		mA
		TXI	$V_I = 3.1 \text{ V}$	100		
			$V_I = 0.3 \text{ V}$	4	10	
		$\overline{\text{RXI}}, \text{RXI}$	$V_{ID} = 0.5 \text{ V}, V_{IC} = 1 \text{ V to } 4.2 \text{ V}$	1000		
I_{OD}	Driver differential output current	Idle	$\overline{\text{TXEN}}$ at 0.8 V, $\overline{\text{LOOP2}}$ at 2 V, $\overline{\text{LOOP1}}$ at 2 V, See Figure 2	± 4		mA
I_{OS}	Short-circuit output current†	R XO, RXEN	V_O at 0 V, RXI at 2 V, $\overline{\text{RXI}}$ at 3 V,	-40	-150	mA
I_{CC}	Supply current	$\overline{\text{LOOP2}}$ at 2 V, TXI at 4.5 V, TXEN at 2 V, Outputs open		225		mA

† Not more than one output should be shorted at a time, and the duration of the test should not exceed 1 second.



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electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (continued)

PARAMETER	TEST CONDITIONST	MIN	MAX	UNIT
Driver fault condition current	TXO shorted to $\overline{\text{TXO}}$, Current measured in short		150	mA
	TXO at 0 V, $\overline{\text{TXO}}$ is open, Current measured at TXO		150	
	TXO is open, $\overline{\text{TXO}}$ at 0, Current measured at $\overline{\text{TXO}}$		150	
	TXO at 0 V, $\overline{\text{TXO}}$ at 0 V, Current measured at TXO and $\overline{\text{TXO}}$		150	
	TXO at 16 V, $\overline{\text{TXO}}$ is open, Current measured at TXO		150	
	TXO is open, $\overline{\text{TXO}}$ at 16 V, Current measured at TXO		150	
	TXO at 16 V, $\overline{\text{TXO}}$ at 16 V, Current measured at TXO and $\overline{\text{TXO}}$		150	
Receiver fault condition current	RXI shorted to $\overline{\text{RXI}}$, Current measured in short		10	mA
	RXI at 0 V, $\overline{\text{RXI}}$ is open, Current measured at RXI		3	
	RXI is open, $\overline{\text{RXI}}$ at 0 V, Current measured at RXI		3	
	RXI at 0 V, $\overline{\text{RXI}}$ at 0 V, Current measured at RXI and $\overline{\text{RXI}}$		3	
	RXI at 16 V, $\overline{\text{RXI}}$ at open, Current measured at RXI		10	
	RXI at open, $\overline{\text{RXI}}$ at 16 V, Current measured at $\overline{\text{RXI}}$		10	
	RXI at 16 V, $\overline{\text{RXI}}$ at 16 V, Current measured at RXI and $\overline{\text{RXI}}$		10	

† Fault conditions should be measured on only one channel at a time.



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switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

driver

PARAMETER		FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	MAX	UNIT
t _{PLH}	Propagation delay time, low-to-high level output	TXI	TXO, $\overline{\text{TXO}}$	TXEN at 2 V, See Figure 3		15	ns
t _{PHL}	Propagation delay time, high-to-low level output	TXI	TXO, $\overline{\text{TXO}}$	TXEN at 2 V, See Figure 3		15	ns
t _{PIL}	Propagation delay time, idle-to-low level output	TXI	TXO, $\overline{\text{TXO}}$	TXEN at 2 V, See Figure 4		25	ns
t _{PIL}	Propagation delay time, idle-to-low level output	TXEN	TXO, $\overline{\text{TXO}}$	TXI at 3.2 V, See Figure 5		25	ns
t _w	Output pulse duration from low-to-high level to 70% output level		TXO, $\overline{\text{TXO}}$	TXEN at 2 V, See Figure 6	260	8000	ns
V _{OD(U)}	Driver output differential undershoot voltage	TXI	TXO, $\overline{\text{TXO}}$	TXEN at 2 V, See Figure 6		-100	mV
t _{sk}	Driver caused signal skew t _{PLH} - t _{PHL}	TXI	TXO, $\overline{\text{TXO}}$	TXEN at 2 V, See Figure 3		±3	ns
t _r	Rise time, TXO, $\overline{\text{TXO}}$			TXEN at 2 V, See Figure 3	1	5	ns
t _f	Fall time, TXO, $\overline{\text{TXO}}$			TXEN at 2 V, See Figure 3	1	5	ns

receiver

PARAMETER		FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	MAX	UNIT
t _{PLH}	Propagation delay time, low-to-high level output	$\overline{\text{RXI}}$, RXI	RXO	V _{IC} = 1 V to 4.2 V, See Figure 10		15	ns
t _{PHL}	Propagation delay time, high-to-low level output	$\overline{\text{RXI}}$, RXI	RXO	V _{IC} = 1 V to 4.2 V, See Figure 10		15	ns
t _{PLH}	Start-up delay time, low-to-high level output	$\overline{\text{RXI}}$, RXI	RXEN	V _{IC} = 1 V to 4.2 V, V _{ID} = -500 mV, See Figure 12		55	ns
t _{PHL}	Shutdown delay time, high-to-low level output	$\overline{\text{RXI}}$, RXI	RXEN	V _{IC} = 1 V to 4.2 V, V _{ID} = 500 mV, See Figure 12	142	181	ns
t _{sk}	Receiver caused signal skew (t _{PLH} - t _{PHL})	$\overline{\text{RXI}}$, RXI	RXO	V _{IC} = 1 V to 4.2 V, V _{ID} = 500 mV, See Figure 10		±3	ns
t _w	Pulse duration at $\overline{\text{RXI}}$ and RXI (to not activate squelch)			V _{IC} = 1 V to 4.2 V, V _{ID} = -175 mV, See Figure 11	25		ns
t _w	Pulse duration at $\overline{\text{RXI}}$ and RXI (to activate squelch)			V _{IC} = 1 V to 4.2 V, V _{ID} = -275 mV, See Figure 11		50	ns
t _{r1}	Rise time, RXO			V _{IC} = 1 V to 4.2 V, V _{ID} = ±500 mV, See Figure 10	1	8	ns
t _{r2}	Rise time, RXEN			V _{IC} = 1 V to 4.2 V, V _{ID} = ±500 mV, See Figure 12	1	8	ns
t _{f1}	Fall time, RXO			V _{IC} = 1 V to 4.2 V, V _{ID} = ±500 mV, See Figure 10	1	8	ns
t _{f2}	Fall time, RXEN			V _{IC} = 2.5 V, V _{ID} = ±500 V, See Figure 12	1	8	ns
t _v	RXO valid after RXEN high			See Figure 10	-10	15	ns



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switching characteristics over recommended ranges of supply voltage and operating free-air temperature

loop

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	MAX	UNIT
t_{PLH} Propagation delay time, low-to-high level output	TXI	RXO	LOOP at 0.8 V, TXEN at 2 V, See Figure 13		30	ns
t_{PHL} Propagation delay time, high-to-low level output	TXI	RXO	LOOP at 0.8 V, TXEN at 2 V, See Figure 13		30	ns
t_{PLH} Propagation delay time, low-to-high level output	TXEN	RXEN	LOOP at 0.8 V, See Figure 14		50	ns
t_{PHL} Propagation delay time, high-to-low level output	TXEN	RXEN	LOOP at 0.8 V, See Figure 14		50	ns

PARAMETER MEASUREMENT INFORMATION

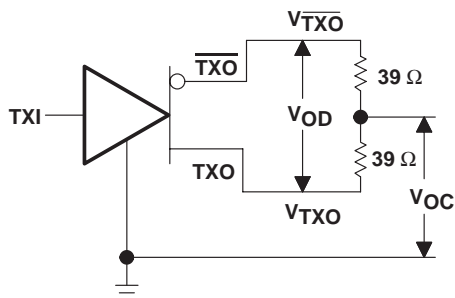


Figure 1. Driver Test Circuit

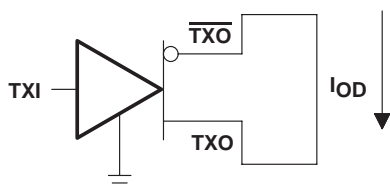
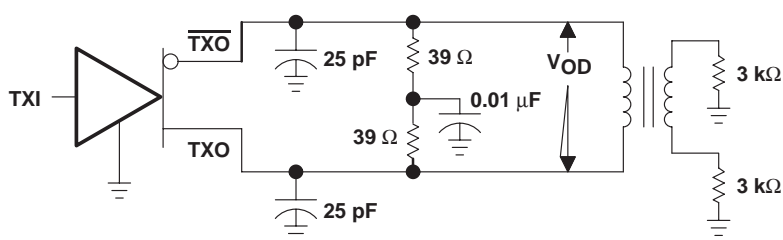


Figure 2. Driver Test Circuit

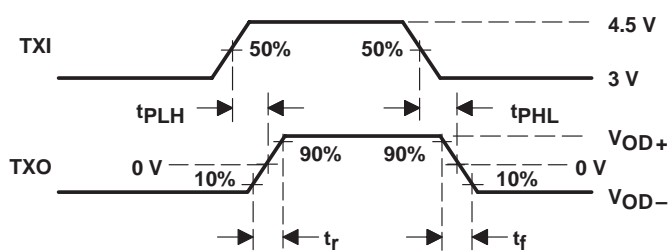
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PARAMETER MEASUREMENT INFORMATION



TEST CIRCUIT



VOLTAGE WAVEFORMS

TRANSFORMER SPECIFICATIONS

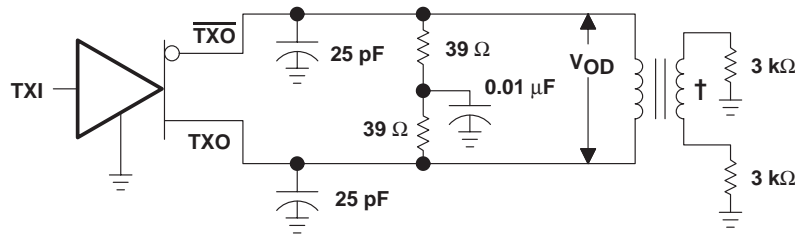
Turns Ratio	1:1
Magnetizing Inductance	26 to 30 μ H
Winding Resistance	0.6 Ω Max
Rise Time 10% to 90%	5 ns Max
Interwinding Capacitance	25 pF
Leakage Inductance	0.25 μ H Max
Inductive Q	1250 Min

Figure 3. Test Circuit and Voltage Waveforms

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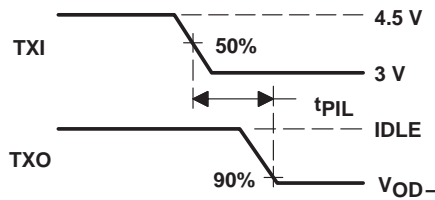
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PARAMETER MEASUREMENT INFORMATION



† See Figure 3

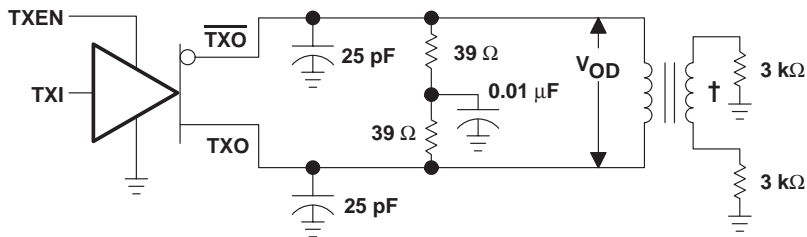
TEST CIRCUIT



VOLTAGE WAVEFORMS

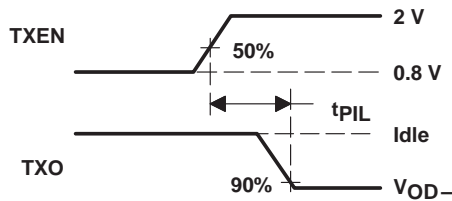
NOTE: Input $t_r \leq 5$ ns; $t_f \leq 5$ ns

Figure 4. Test Circuit and Voltage Waveforms



† See Figure 3

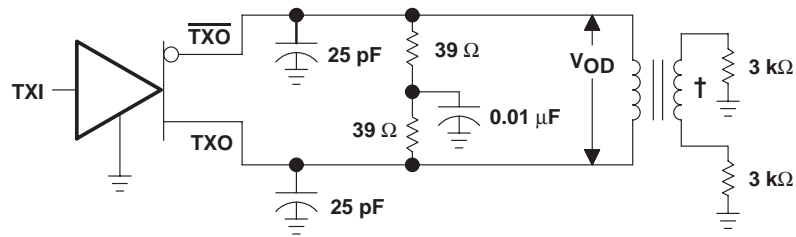
TEST CIRCUIT



VOLTAGE WAVEFORMS

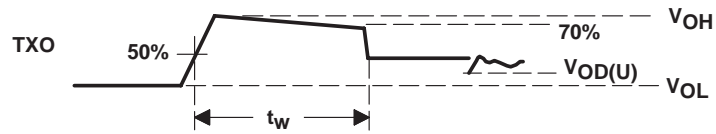
Figure 5. Test Circuit and Voltage Waveforms

PARAMETER MEASUREMENT INFORMATION



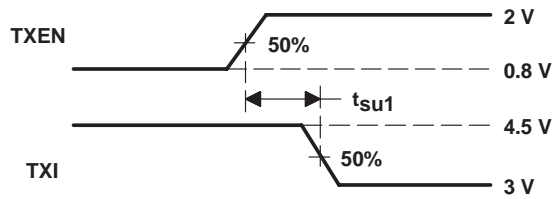
† See Figure 3

TEST CIRCUIT



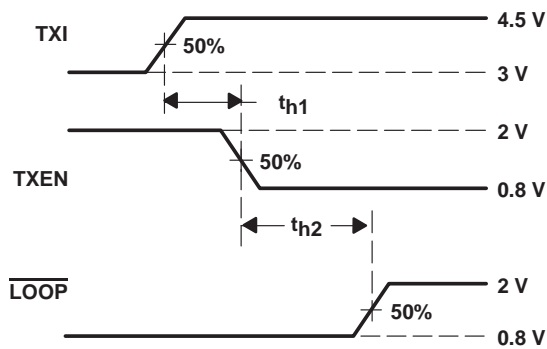
VOLTAGE WAVEFORMS

Figure 6. Test Circuit and Voltage Waveforms



NOTE: Input $t_r \leq 5$ ns; $t_f \leq 5$ ns

Figure 7



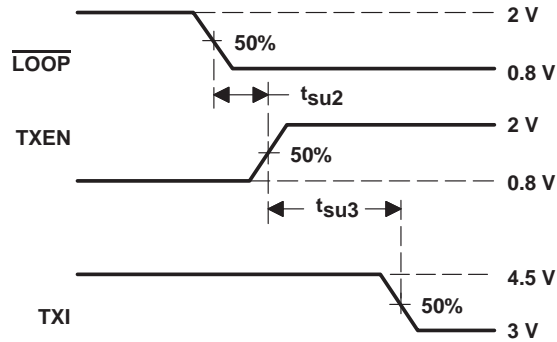
NOTE: Input $t_r \leq 5$ ns; $t_f \leq 5$ ns

Figure 8

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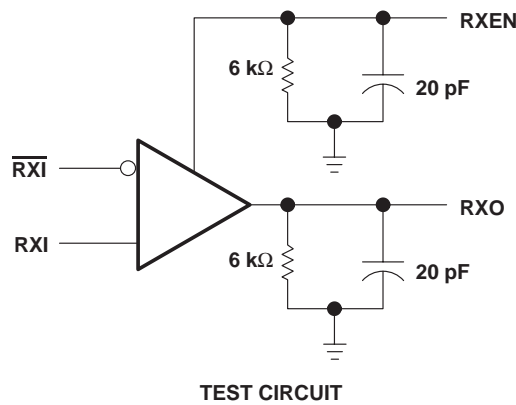
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PARAMETER MEASUREMENT INFORMATION

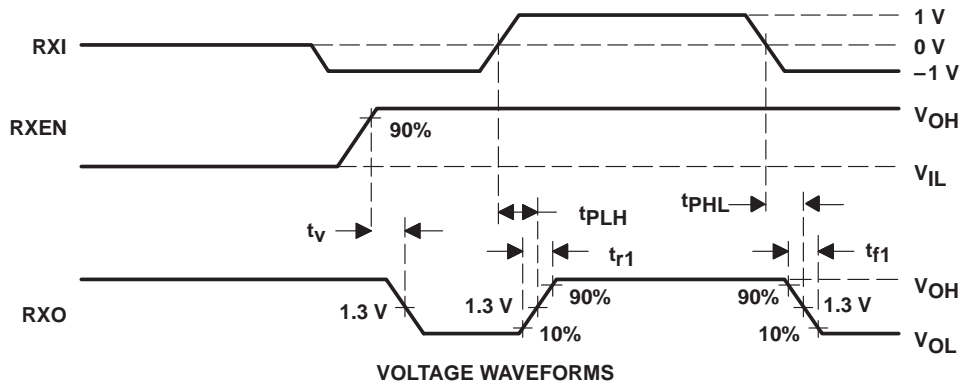


NOTE: Input $t_r \leq 5$ ns; $t_f \leq 5$ ns

Figure 9



TEST CIRCUIT



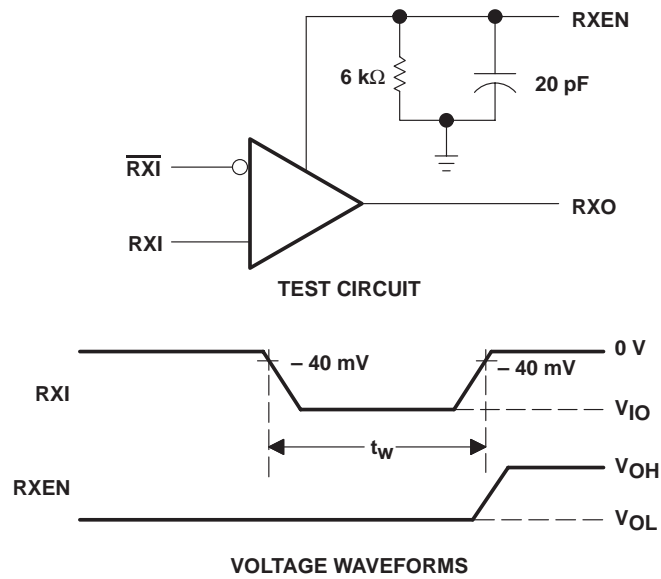
NOTE: Input $t_r \leq 5$ ns; $t_f \leq 5$ ns

Figure 10. Test Circuit and Voltage Waveforms



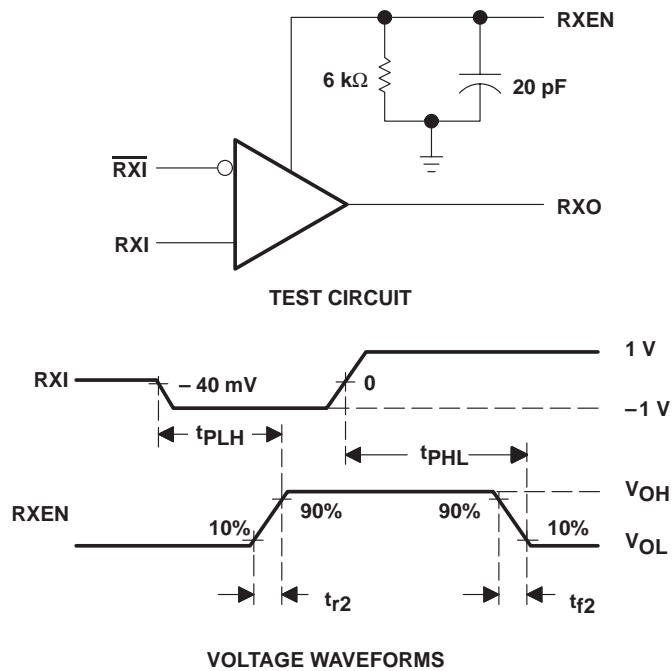
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PARAMETER MEASUREMENT INFORMATION



NOTE: Input $t_r \leq 5$ ns; $t_f \leq 5$ ns

Figure 11. Test Circuit and Voltage Waveforms



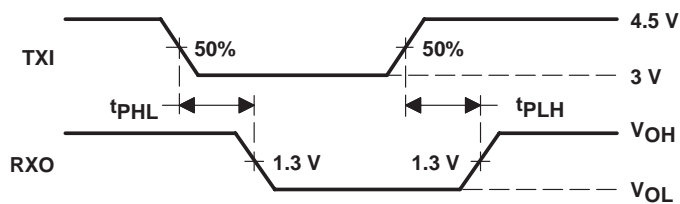
NOTE: Input $t_r \leq 5$ ns; $t_f \leq 5$ ns

Figure 12. Test Circuit and Voltage Waveforms

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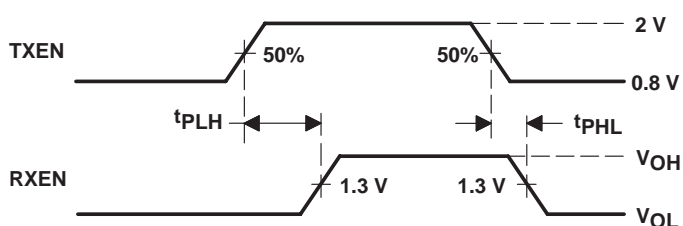
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PARAMETER MEASUREMENT INFORMATION



NOTE: Input $t_r \leq 5$ ns; $t_f \leq 5$ ns

Figure 13



NOTE: Input $t_r \leq 5$ ns; $t_f \leq 5$ ns

Figure 14

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